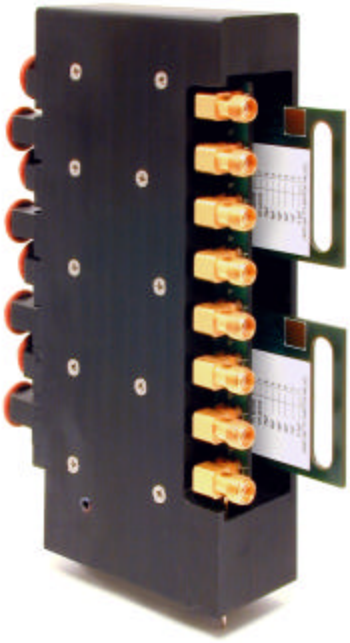
S&A VARIABLE CAPACITANCE LOAD CARD TEMPERATURE TEST HEAD

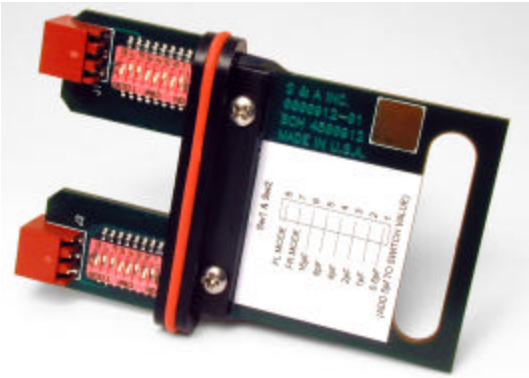
NEW

- **Variable capacitance load card test head for crystal temperature test systems**
- **Load card DIP switch selects either FR or FL measurement**
- **FL measurement physical capacitance can be set from 5 to 37 pF in 0.5 pF steps**
- **Integral moisture barriers support repeatable FL testing**
- **Design optimized for correlation to industry standard test equipment**

Dual Row Test Head

Quad Disc Test Head





Variable Capacitance Load Card

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